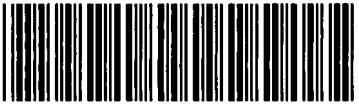


<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10644009	TAKEUCHI ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Tran, Philip B	2155

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
709	245, 242, 238, 225, 227-228, 230	6/20/2007	PBT
370	392-393, 466, 389,400	6/20/2007	PBT

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
East and NPL	6/20/07	PBT

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>